GSM22N10DF

100V N-Channel MOSFETs

Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

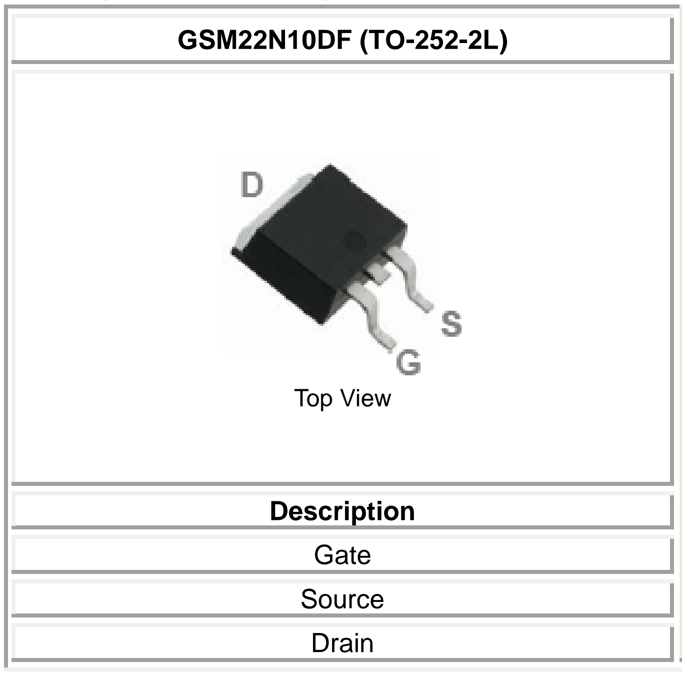
Features

- 100V, 40A, $R_{DS(ON)}$=24mΩ@V_{GS}=10V
- Improved dv/dt capability
- Fast switching
- 100% EAS guaranteed
- Green Device Available
- TO-252-2L package design

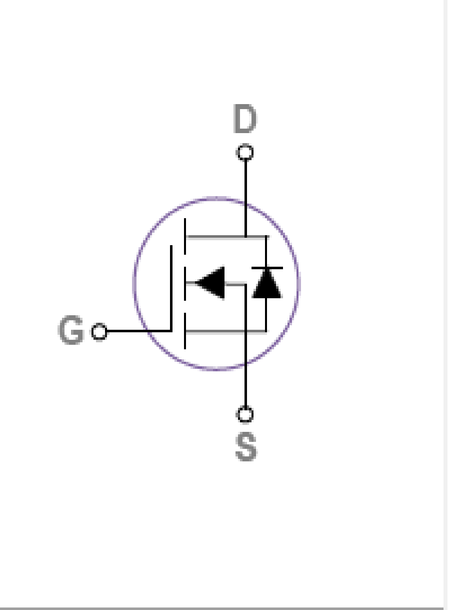
Applications

- Networking
- Load Switch
- LED applications

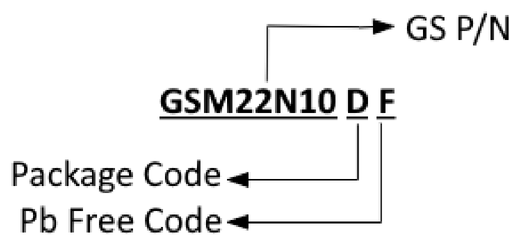
Packages & Pin Assignments



Description
Gate
Source
Drain

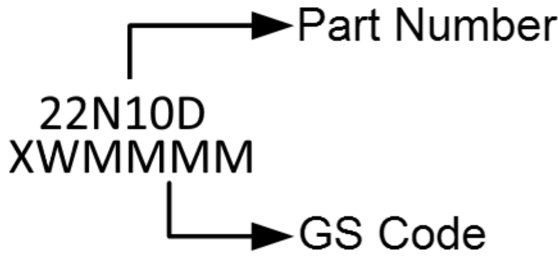


Ordering Information



Part Number	Package	Quantity Reel
GSM22N10DF	TO-252-2L	2500 PCS

Marking Information



Absolute Maximum Ratings

T_C=25ºC Unless otherwise noted

Symbol	Parameter		Typical	Unit
V_{DS}	Drain-Source Voltage		100	V
V_{GS}	Gate-Source Voltage		±20	V
I_D	Continuous Drain Current[1]	T_C=25℃	40	A
		T_C=70℃	22	
I_{DM}	Pulsed Drain Current[2]		75	A
EAS	Single Pulse Avalanche Energy[3]		16	mJ
I_{AS}	Single Pulse Avalanche Current		18	A
P_D	Power Dissipation T_C=25℃		62.5	W
T_J	Operating Junction Temperature Range		-50 to +150	℃
T_{STG}	Storage Temperature Range		-50 to +150	℃
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		50	℃/W
$R_{\theta JC}$	Thermal Resistance-Junction to Case		2	℃/W

Electrical Characteristics

T_J=25℃ Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250uA	100			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250uA	1	2	3	V
I_{GSS}	Gate Leakage Current	V_{DS}=0V, V_{GS}=±20V			±100	nA
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=100V, V_{GS}=0V			1	uA
I_S	Continuous Source Current	V_G=V_D=0V, Force Current			40	A
$R_{DS(on)}$	Drain-Source On-Resistance[2]	V_{GS}=10V, I_D=25A		18	24	mΩ
		V_{GS}=4.5V, I_D=6A		19	38	mΩ
g_{FS}	Forward Transconductance	V_{DS}=10V, I_D=3A		14		S
V_{SD}	Diode Forward Voltage	V_{GS}=0V, I_S=1A			1	V
Dynamic						
C_{iss}	Input Capacitance	V_{DS}=15V, V_{GS}=0V, f=1MHz		1930		pF
C_{oss}	Output Capacitance			245		
C_{rss}	Reverse Transfer Capacitance			125		
R_g	Gate Resistance	V_{DS}=0V, V_{GS}=0V, f=1MHz		1.6		Ω
Q_g	Total Gate Charge	V_{DS}=80V, V_{GS}=10V, I_D=7A		36		nC
Q_{gs}	Gate-Source Charge			5		
Q_{gd}	Gate-Drain Charge			10		
$t_{d(on)}$	Turn-On Time	V_{DD}=50V, I_D=3.3A, V_{GS}=10V, R_G=7Ω		11.5		ns
t_r				29		
$t_{d(off)}$	Turn-Off Time			42		
t_f				18		

Note :
1.The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
2.The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
3.The EAS data shows Max. rating. The test condition is V_{DD}=25V, V_{GS}=10V, L=0.1mH.

Typical Performance Characteristics

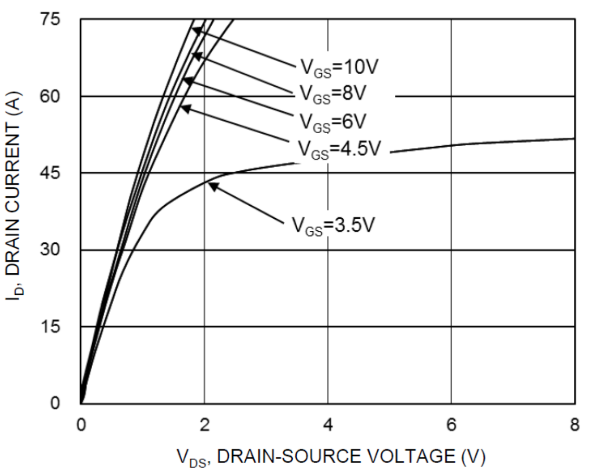


Fig. 1 Typical Output Characteristics

100
80
60
40
20
0
2
4
6
8
10
I_D=25A
$R_{DS(ON)}$, DRAIN-SOURCE ON-RESISTANCE (Ω)
V_{GS}, GATE-SOURCE VOLTAGE (V)

Fig. 2 Typical Transfer Characteristics

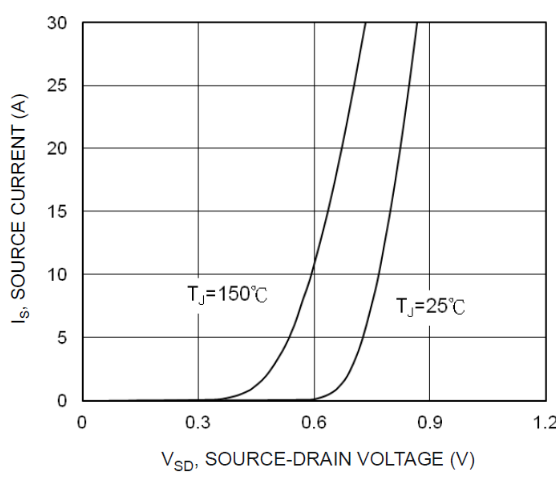


Fig. 3 Diode Forward Voltage vs. Current

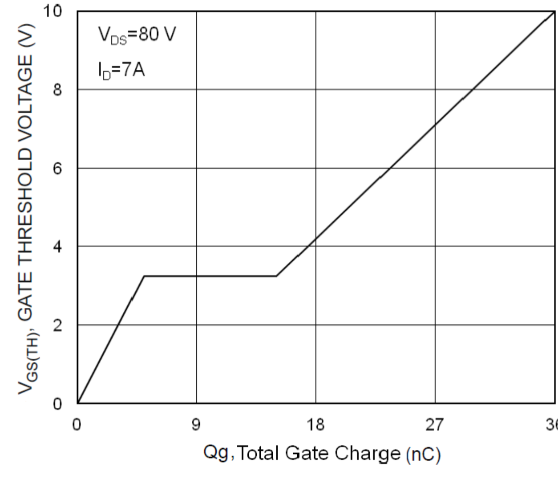


Fig. 4 Gate Charge

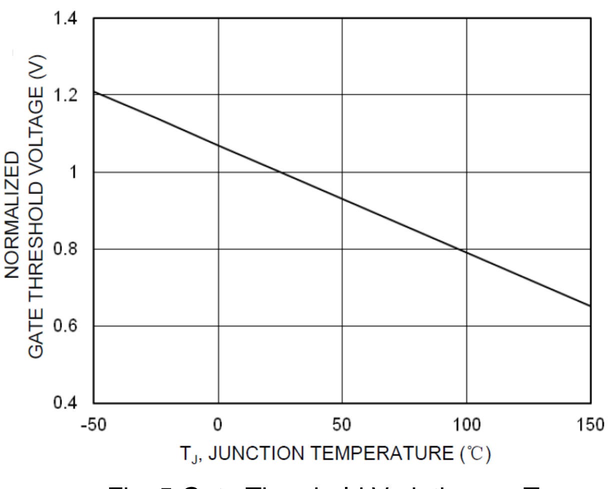


Fig. 5 Gate Threshold Variation vs. T_J

2.2
1.8
1.4
1.0
0.6
0.2
-50
0
50
100
150
R_{DSON}, DRAIN-SOURCE ON-RESISTANCE (NORMALIZED)
T_J, JUNCTION TEMPERATURE (℃)

Fig. 6 On-Resistance Variation with T_J

Typical Performance Characteristics (continue)

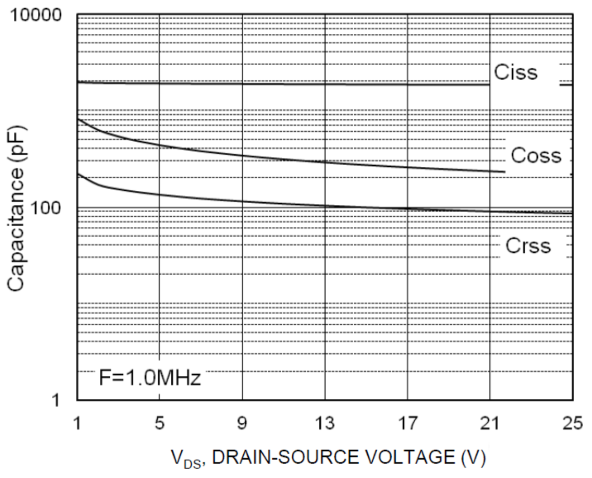


Fig. 7 Typical Capacitance

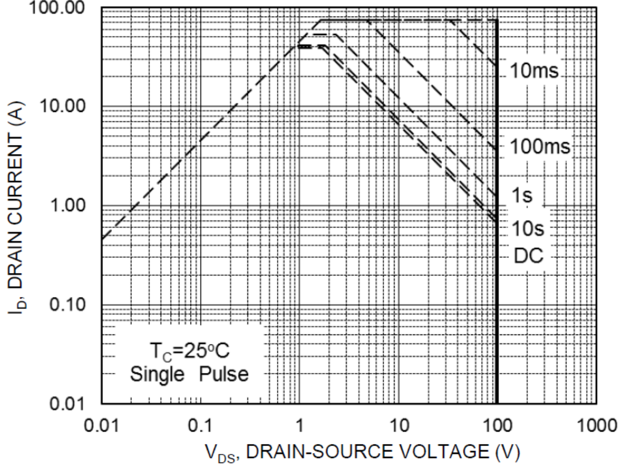


Fig. 8 Safe Operating Area

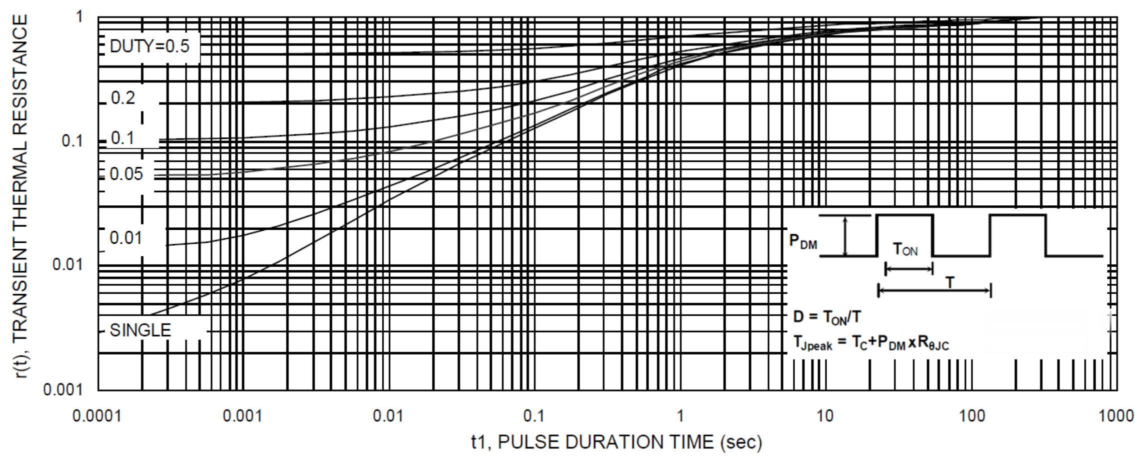
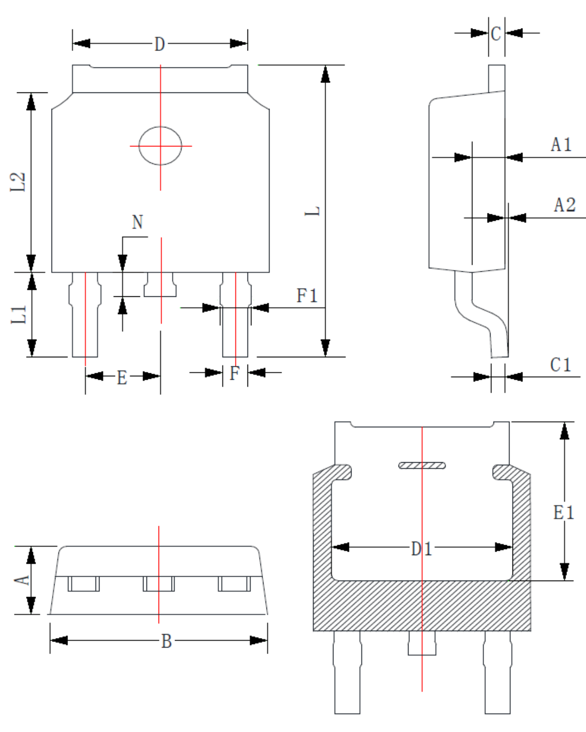


Fig. 9 Transient Thermal Response

Package Dimension

TO252-2L



SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	2.200	2.400	0.087	0.094
A1	0.910	1.110	0.036	0.043
A2	-	0.250	-	0.010
B	6.500	6.700	0.256	0.264
C	0.400	0.600	0.016	0.023
C1	0.400	0.600	0.016	0.023
D	5.150	5.450	0.203	0.214
D1	5.100	5.400	0.200	0.212
E	2.200	2.400	0.087	0.094
E1	4.950	5.350	0.195	0.210
F	0.660	0.860	0.026	0.034
F1	0.700	0.950	0.028	0.037
L	9.700	10.100	0.382	0.397
L1	2.670	3.070	0.105	0.121
L2	6.000	6.200	0.236	0.244
N	0.600	1.000	0.024	0.039

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